

TEST REPORT

FCC LTE B13 Test for SM-F741B

Certification

APPLICANT SAMSUNG Electronics Co., Ltd.

REPORT NO. HCT-RF-2405-FC005

DATE OF ISSUE May 3, 2024

Tested by Jae Mun Do

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TEST REPORT

REPORT NO. HCT-RF-2405-FC005

DATE OF ISSUE May 03, 2024

Additional Model

-

Applicant	SAMSUNG Electronics Co., Ltd. 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
Product Name	Mobile Phone
Model Name	SM-F741B
Date of Test	March 12, 2024 ~ April 29, 2024
FCC ID	A3LSMF741B
Location of Test	■ Permanent Testing Lab □ On Site Testing (Address: 74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggido, 17383 Republic of Korea)
FCC Classification:	PCS Licensed Transmitter Held to Ear (PCE)
FCC Rule Part(s):	§ 27

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REVISION HISTORY

The revision history for this test report is shown in table.

Revision No.	Date of Issue	Description
0	May 03, 2024	Initial Release

Notice

Content

The measurements shown in this report were made in accordance with the procedures specified in CFR47 section § 2.947. I assume full responsibility for the accuracy and completeness of these measurements, and for the qualifications of all persons taking them.

HCT CO., LTD. Certifies that no party to this application has subject to a denial of Federal benefits that includes FCC benefits pursuant to section 5301 of the Anti-Drug Abuse Act of 1998,21 U.S. C.853(a)

The results shown in this test report only apply to the sample(s), as received, provided by the applicant, unless otherwise stated.

The test results have only been applied with the test methods required by the standard(s).

When confirmation of authenticity of this test report is required, please contact www.hct.co.kr

The test results in this test report are not associated with the ((KS Q) ISO/IEC 17025) accreditation by KOLAS (Korea Laboratory Accreditation Scheme) / A2LA (American Association for Laboratory Accreditation) that are under the ILAC (International Laboratory Accreditation Cooperation) Mutual Recognition Agreement (MRA).

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MEASUREMENT REPORT

1. GENERAL INFORMATION

Applicant Name:	SAMSUNG Electronics Co., Ltd.
Address:	129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
FCC ID:	A3LSMF741B
Application Type:	Certification
FCC Classification:	PCS Licensed Transmitter Held to Ear (PCE)
FCC Rule Part(s):	§ 27
EUT Type:	Mobile phone
Model(s):	SM-F741B
Additional Model(s)	-
Tx Frequency:	779.5 MHz –784.5 MHz (LTE – Band 13 (5 MHz)) 782 MHz (LTE – Band 13 (10 MHz))
Date(s) of Tests:	March 12, 2024 ~ April 29, 2024
Serial number:	Radiated: R3CX20CZ00N Conducted: R3CX30N96FZ

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1.1. MAXIMUM OUTPUT POWER

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Mode (MHz)	Tx Frequency (MHz)	Emission Designator	Modulation	Max. Power (W)	Max. Power (dBm)
		4M52G7D	QPSK	0.140	21.45
LTC Dand12 (E)	779.5 –784.5	4M50W7D	16QAM	0.119	20.74
LTE – Band13 (5)	119.5 -164.5	4M50W7D	64QAM	0.094	19.73
		4M53W7D	256QAM	0.045	16.53
LTE – Band13 (10) 782.0		9M00G7D	QPSK	0.144	21.59
	792.0	8M98W7D	16QAM	0.119	20.76
	102.0	9M00W7D	64QAM	0.095	19.77
		9M01W7D	256QAM	0.046	16.60

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2. INTRODUCTION

2.1. DESCRIPTION OF EUT

The EUT was a Mobile Phone with GSM/GPRS/EGPRS/UMTS and LTE, Sub 6. It also supports IEEE 802.11 a/b/g/n/ac/ax (20/40/80/160 MHz), Bluetooth(iPA, ePA), BT LE(iPA, ePA), NFC, WPT, WIFI 6E.

2.2. MEASURING INSTRUMENT CALIBRATION

The measuring equipment, which was utilized in performing the tests documented herein, has been calibrated in accordance with the manufacturer's recommendations for utilizing calibration equipment, which is traceable to recognized national standards.

2.3. TEST FACILITY

The Fully-anechoic chamber and conducted measurement facility used to collect the radiated data are located at the **74**, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383, Rep. of KOREA.

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3. DESCRIPTION OF TESTS

3.1 TEST PROCEDURE

Test Description	Test Procedure Used
Occupied Bandwidth	- KDB 971168 D01 v03r01 – Section 4.3 - ANSI C63.26-2015 – Section 5.4.4
Band Edge	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Spurious and Harmonic Emissions at Antenna Terminal	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Conducted Output Power	- N/A (See SAR Report)
Frequency stability	- ANSI C63.26-2015 – Section 5.6
Effective Radiated Power/ Effective Isotropic Radiated Power	- KDB 971168 D01 v03r01 – Section 5.2 & 5.8 - ANSI/TIA-603-E-2016 – Section 2.2.17
Radiated Spurious and Harmonic Emissions	- KDB 971168 D01 v03r01 – Section 6.2 - ANSI/TIA-603-E-2016 – Section 2.2.12

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3.2 RADIATED POWER

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.

The equipment under test is placed on a non-conductive table 3-meters away from the receive antenna in accordance with ANSI/TIA-603-E-2016 Clause 2.2.17.

Test Settings

- 1. Radiated power measurements are performed using the signal analyzer's "channel power" measurement capability for signals with continuous operation.
- 2. RBW = 1 5% of the expected OBW, not to exceed 1 MHz
- $3.VBW \ge 3 \times RBW$
- 4. Span = 1.5 times the OBW
- 5. No. of sweep points > 2 x span / RBW
- 6. Detector = RMS
- 7. Trigger is set to "free run" for signals with continuous operation with the sweep times set to "auto".
- 8. The integration bandwidth was roughly set equal to the measured OBW of the signal for signals with continuous operation.
- 9. Trace mode = trace averaging (RMS) over 100 sweeps
- 10. The trace was allowed to stabilize

Test Note

- 1. The turntable is rotated through 360 degrees, and the receiving antenna scans in order to determine the level of the maximized emission.
- 2. A half wave dipole is then substituted in place of the EUT. For emissions above 1 GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated.

The power is calculated by the following formula;

 $P_{d (dBm)} = Pg_{(dBm)} - cable loss_{(dB)} + antenna gain_{(dB)}$

Where: P_d is the dipole equivalent power and P_g is the generator output power into the substitution antenna.

- 3. The maximum value is calculated by adding the forward power to the calibrated source plus its appropriate gain value.
 - These steps are repeated with the receiving antenna in both vertical and horizontal polarization. the difference between the gain of the horn and an isotropic antenna are taken into consideration
- 4. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
- 5. All measurements are performed as RMS average measurements while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

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3.3 RADIATED SPURIOUS EMISSIONS

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.

Radiated Spurious Emission Measurements at 3 meters by Substitution Method according to ANSI/TIA-603-E-2016.

Test Settings

- 1. RBW = 100 kHz for emissions below 1 GHz and 1 MHz for emissions above 1 GHz
- $2. VBW \ge 3 \times RBW$
- 3. Span = 1.5 times the OBW
- 4. No. of sweep points > 2 x span / RBW
- 5. Detector = Peak
- 6. Trace mode = Max Hold
- 7. The trace was allowed to stabilize
- 8. Test channel: Low/ Middle/ High
- 9. Frequency range: We are performed all frequency to 10th harmonics from 9 kHz.

Test Note

- 1. Measurements value show only up to 3 maximum emissions noted, or would be lesser if no specific emissions from the EUT are recorded (ie: margin > 20 dB from the applicable limit) and considered that's already beyond the background noise floor.
- 2. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
 - The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the test data
- For spurious emissions above 1 GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated.

The spurious emissions is calculated by the following formula;

Result (dBm) = Pg (dBm) - cable loss (dB) + antenna gain (dBi)

Where: Pg is the generator output power into the substitution antenna.

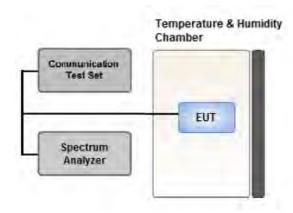
If the fundamental frequency is below 1 GHz, RF output power has been converted to EIRP.

EIRP (dBm) = ERP (dBm) + 2.15

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3.4 OCCUPIED BANDWIDTH.



Test setup

The width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5 % of the total mean power of a given emission.

The EUT makes a call to the communication simulator.

The conducted occupied bandwidth used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer.

The communication simulator station system controlled a EUT to export maximum output power under transmission mode and specific channel frequency. Use OBW measurement function of Spectrum analyzer to measure 99 % occupied bandwidth

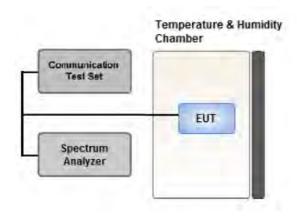
Test Settings

- 1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99 % occupied bandwidth and the 26 dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
- 2. RBW = 1 5 % of the expected OBW
- 3. VBW \geq 3 x RBW
- 4. Detector = Peak
- 5. Trace mode = max hold
- 6. Sweep = auto couple
- 7. The trace was allowed to stabilize
- 8. If necessary, steps 2 7 were repeated after changing the RBW such that it would be within
 - 1-5% of the 99 % occupied bandwidth observed in Step 7

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3.5 SPURIOUS AND HARMONIC EMISSIONS AT ANTENNA TERMINAL



Test setup

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic.

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

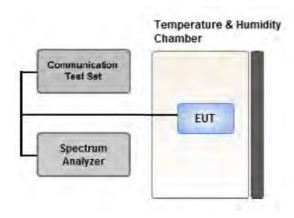
Test Settings

- 1. RBW = 1 MHz
- 2. VBW \geq 3 MHz
- 3. Detector = RMS
- 4. Trace Mode = trace average
- 5. Sweep time = auto
- 6. Number of points in sweep ≥ 2 x Span / RBW

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3.6 BAND EDGE



Test setup

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Settings

- 1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
- 2. Span was set large enough so as to capture all out of band emissions near the band edge
- 3. RBW > 1 % of the emission bandwidth
- $4. VBW > 3 \times RBW$
- 5. Detector = RMS
- 6. Number of sweep points $\geq 2 \times \text{Span/RBW}$
- 7. Trace mode = trace average
- 8. Sweep time = auto couple
- 9. The trace was allowed to stabilize

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Test Notes

According to FCC 22.917, 24.238, 27.53 specified that power of any emission outside of The authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.

In the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.

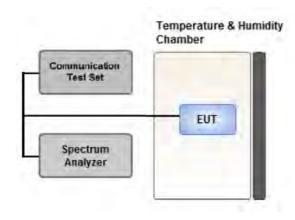
All measurements were done at 2 channels(low and high operational frequency range.) The band edge measurement used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer.

Where Margin < 1 dB the emission level is either corrected by $10 \log(1 \text{ MHz/ RB})$ or the emission is integrated over a 1 MHz bandwidth to determine the final result. When using the integration method the integration window is either centered on the emission or, for emissions at the band edge, centered by an offset of 500 kHz from the block edge so that the integration window is the 1 MHz adjacent to the block edge.

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3.7 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE



Test setup

Test Overview

Frequency stability testing is performed in accordance with the guidelines of ANSI C63.26-2015. The frequency stability of the transmitter is measured by:

1. Temperature:

The temperature is varied from -30 $^{\circ}$ C to +50 $^{\circ}$ C in 10 $^{\circ}$ C increments using an environmental chamber.

- 2. Primary Supply Voltage:
 - .- Unless otherwise specified, vary primary supply voltage from 85 % to 115 % of the nominal value for other than hand carried battery equipment.
 - .- For hand carried, battery powered equipment, reduce the primary ac or dc supply voltage to the battery operating end point, which shall be specified by the manufacturer.

Test Settings

- 1. The carrier frequency of the transmitter is measured at room temperature (20 °C to provide a reference).
- 2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
- 3. Frequency measurements are made at 10 °C intervals ranging from -30 °C to +50 °C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

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3.8 WORST CASE(RADIATED TEST)

- The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.

- All modes of operation were investigated and the worst case configuration results are reported.

Mode: Stand alone, Stand alone + External accessories (Earphone, AC adapter, etc)

Worst case: Stand alone

- We were performed the RSE test in condition of co-location.

Mode: Stand alone, Simultaneous transmission scenarios

Worst case: Stand alone

- The EUT was tested in three modes (Open, Half-open, Closed), the worst case configuration results are reported.

Worst case: Open mode.

- The worst case is reported with the EUT positioning, modulations, and paging service configurations shown in the test data
- Please refer to the table below.

[Worst case]

Test Description	Modulation	RB size	RB offset	Axis
	QPSK,	See Section 8.1		
Effective Radiated Power	16QAM,			V
	64QAM,			Y
	256QAM			
Radiated Spurious and Harmonic Emissions	QPSK	See Se	ction 8.2	Х

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3.9 WORST CASE(CONDUCTED TEST)

- All modes of operation were investigated and the worst case configuration results are reported.

[Worst case]

Test Description	Modulation	Bandwidth (MHz)	Frequency	RB size	RB offset
Occupied Bandwidth	QPSK, 16QAM, 64QAM, 256QAM	5, 10	Mid	Full RB	0
	QPSK	5	Low High	1	0 24
Band Edge		10	Low	1	0 49
		5, 10	Low, High	Full RB	0
Spurious and Harmonic Emissions at Antenna Terminal	QPSK	5, 10	Low, Mid, High	1	0

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4. LIST OF TEST EQUIPMENT

Equipment	Model	Manufacturer	Serial No.	Due to Calibration	Calibration Interval
RF Switching System	FBSR-02B(1.2G HPF+LNA)	T&M SYSTEM	F1L1	12/11/2024	Annual
RF Switching System	FBSR-02B(3.3G HPF+LNA)	T&M SYSTEM	F1L2	12/11/2024	Annual
Power Splitter(DC ~ 26.5 GHz)	11667B	Hewlett Packard	5001	04/17/2025	Annual
DC Power Supply	E3632A	Agilent	MY40010147	06/23/2024	Annual
Dipole Antenna	UHAP	Schwarzbeck	557	03/09/2025	Biennial
Dipole Antenna	UHAP	Schwarzbeck	558	03/09/2025	Biennial
Chamber	SU-642	ESPEC	93008124	02/19/2025	Annual
Horn Antenna(1 ~ 18 GHz)	BBHA 9120D	Schwarzbeck	147	08/17/2025	Biennial
Horn Antenna(1 ~ 18 GHz)	BBHA 9120D	Schwarzbeck	9120D-1298	09/11/2025	Biennial
Horn Antenna(15 ~ 40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170342	09/29/2024	Biennial
Horn Antenna(15 ~ 40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170124	03/28/2025	Biennial
Signal Analyzer(10 Hz ~ 26.5 GHz)	N9020A	Agilent	MY52090906	04/19/2025	Annual
ATTENUATOR(20 dB)	8493C	Hewlett Packard	17280	04/17/2025	Annual
Spectrum Analyzer(10 Hz ~ 40 GHz)	FSV40	REOHDE & SCHWARZ	100931	08/17/2024	Annual
Base Station	8960 (E5515C)	Agilent	MY48360800	08/10/2024	Annual
Loop Antenna(9 kHz ~ 30 MHz)	FMZB1513	Schwarzbeck	1513-333	03/07/2026	Biennial
Trilog Broadband Antenna	VULB9168	Schwarzbeck	895	09/16/2024	Biennial
Trilog Broadband Antenna	VULB9168	Schwarzbeck	1135	09/16/2024	Biennial
Wideband Radio Communication Tester	MT8821C	Anritsu Corp.	6262094331	11/17/2024	Annual
Wideband Radio Communication Tester	MT8820C	Anritsu Corp.	6201026545	12/11/2024	Annual
SIGNAL GENERATOR (100 kHz ~ 40 GHz)	SMB100A	REOHDE & SCHWARZ	177633	06/22/2024	Annual
Signal Analyzer(5 Hz ~ 40.0 GHz)	N9030B	KEYSIGHT	MY55480167	05/24/2024	Annual
FCC LTE Mobile Conducted RF Automation Test Software	-	HCT CO., LTD.,	-	-	-

Note:

- 1. Equipment listed above that has a calibration due date during the testing period, the testing is completed before equipment expiration date.
- 2. Especially, all antenna for measurement is calibrated in accordance with the requirements of C63.5 (Version : 2017).

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5. MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4:2014.

All measurement uncertainty values are shown with a coverage factor of k=2 to indicate a 95 % level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Parameter	Expanded Uncertainty (±dB)
Conducted Disturbance (150 kHz ~ 30 MHz)	1.98 (Confidence level about 95 %, <i>k</i> =2)
Radiated Disturbance (9 kHz ~ 30 MHz)	4.36 (Confidence level about 95 %, <i>k</i> =2)
Radiated Disturbance (30 MHz ~ 1 GHz)	5.70 (Confidence level about 95 %, <i>k</i> =2)
Radiated Disturbance (1 GHz ~ 18 GHz)	5.52 (Confidence level about 95 %, <i>k</i> =2)
Radiated Disturbance (18 GHz ~ 40 GHz)	5.66 (Confidence level about 95 %, <i>k</i> =2)
Radiated Disturbance (Above 40 GHz)	5.58 (Confidence level about 95 %, <i>k</i> =2)

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6. SUMMARY OF TEST RESULTS

6.1 Test Condition: Conducted Test

Test Description	FCC Part Section(s)	Test Limit	Test Result
Occupied Bandwidth	§ 2.1049	N/A	PASS
Band Edge / Spurious and Harmonic Emissions at Antenna Terminal.	§ 2.1051, § 27.53(c)	< 43 + 10log10 (P[Watts]) at Band Edge and for all out-of-band emissions	PASS
On all frequencies between 763-775 MHz and 793-805 MHz.	§ 27.53(c)(4)	< 65 + 10log10 (P[Watts])	PASS (See Note2)
Conducted Output Power	§ 2.1046	N/A	See Note1
Frequency stability / variation of ambient temperature	§ 2.1055, § 27.54	Emission must remain in band	PASS

Note:

- 1. See SAR Report
- 2. Since it was not possible to set the resolution bandwidth to 6.25 kHz with the available equipment, a bandwidth of 10 kHz was used instead to show compliance.

6.2 Test Condition: Radiated Test

Test Description	FCC Part Section(s)	Test Limit	Test Result	
Effective Radiated Power	§ 27.50(b)(10)	< 3 Watts max. ERP	PASS	
Radiated Spurious and	ous and § 2.1053, < 43 + 10log10 (P[Watts]) for		PASS	
Harmonic Emissions	§ 27.53(c)	all out-of band emissions	PASS	
Undesirable Emissions in	§ 2.1053,	<-70dBW/MHz EIRP (wideband)	PASS	
the 1559 – 1610 MHz band	27.53(f)	<-80dBW EIRP (narrowband)	PASS	

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7. SAMPLE CALCULATION

7.1 ERP Sample Calculation

Ch./ Freq.		Measured	Substitute	Ant. Gain			EF	RP
channel	Freq.(MHz)	Level (dBm)	Level (dBm)	(dBd)	C.L	Pol.	w	dBm
128	824.20	-21.37	38.40	-10.61	0.95	Н	0.483	26.84

ERP = Substitute LEVEL(dBm) + Ant. Gain - CL(Cable Loss)

- 1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
- 2) During the test, the turn table is rotated until the maximum signal is found.
- 3) Record the field strength meter's level.
- 4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
- 5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
- 6) The signal generator output level with Ant. Gain and cable loss are the rating of effective radiated power.

7.2 EIRP Sample Calculation

Ch./ Freq.		Measured	Substitute	Ant. Gain			EIRP	
channel	Freq.(MHz)	Level (dBm)	Level (dBm)	(dBi)	C.L	Pol.	w	dBm
20175	1,732.50	-15.75	18.45	9.90	1.76	Н	0.456	26.59

EIRP = Substitute LEVEL(dBm) + Ant. Gain - CL(Cable Loss)

- 1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
- 2) During the test, the turn table is rotated until the maximum signal is found.
- 3) Record the field strength meter's level.
- 4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
- 5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
- 6) The signal generator output level with Ant. Gain and cable loss are the rating of equivalent isotropic radiated power.

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7.3. Emission Designator

GSM Emission Designator

Emission Designator = 249KGXW

GSM BW = 249 kHz G = Phase Modulation

X = Cases not otherwise covered

W = Combination (Audio/Data)

EDGE Emission Designator

Emission Designator = 249KG7W

GSM BW = 249 kHz

G = Phase Modulation

7 = Quantized/Digital Info

W = Combination (Audio/Data)

WCDMA Emission Designator

Emission Designator = 4M17F9W

WCDMA BW = 4.17 MHz F = Frequency Modulation

9 = Composite Digital Info

W = Combination (Audio/Data)

QPSK Modulation

Emission Designator = 4M48G7D

LTE BW = 4.48 MHz

G = Phase Modulation

7 = Quantized/Digital Info

D = Data transmission; telemetry; telecommand

QAM Modulation

Emission Designator = 4M48W7D

LTE BW = 4.48 MHz

W = Amplitude/Angle Modulated

7 = Quantized/Digital Info

D = Data transmission; telemetry; telecommand

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8. TEST DATA

8.1 EFFECTIVE RADIATED POWER

	14 a d /		Measured	Substitute	Ant Cain			Limit	El	RP	ı	RB
Freq (MHz)	Mod/ Bandwidth	Modulation	Level (dBm)	Level (dBm)	Ant. Gain (dBd)	C.L	Pol	W	W	dBm	Size	Offset
		QPSK	-29.70	32.63	-9.85	1.36	V		0.139	21.42		
770 F		16-QAM	-30.44	31.89	-9.85	1.36	V		0.117	20.68	1	0
779.5		64-QAM	-31.49	30.84	-9.85	1.36	٧		0.092	19.63	1	0
		256-QAM	-34.70	27.63	-9.85	1.36	٧		0.044	16.42		
		QPSK	-29.83	32.66	-9.85	1.36	٧		0.140	21.45		
702.0	LTE B13	16-QAM	-30.54	31.95	-9.85	1.36	٧	12.00	0.119	20.74	1	0
782.0	(5 MHz)	64-QAM	-31.55	30.94	-9.85	1.36	٧	< 3.00	0.094	19.73	1	0
		256-QAM	-34.75	27.74	-9.85	1.36	٧		0.045	16.53		
		QPSK	-30.09	32.49	-9.85	1.36	V		0.134	21.28		
704.5		16-QAM	-30.81	31.77	-9.85	1.36	V	_	0.114	20.56	1	0
784.5		64-QAM	-31.85	30.73	-9.85	1.36	V		0.090	19.52	1	
		256-QAM	-35.00	27.58	-9.85	1.36	V		0.043	16.37		

Freq (MHz)	Mod/ Bandwidth	Modulation	Measured Substitute Ant. Gain		<u>_</u>	Limit	El	RP		RB		
			Level (dBm)	Level (dBm)	(dBd)	C.L	Pol	W	w	dBm	Size	Offset
		QPSK	-29.69	32.80	-9.85	1.36	٧		0.144	21.59		
702.0	LTE B13	16-QAM	-30.52	31.97	-9.85	1.36	٧	- 2.00	0.119	20.76	1	0
782.0	(10 MHz)	64-QAM	-31.51	30.98	-9.85	1.36	٧	< 3.00	0.095	19.77	1	0
		256-QAM	-34.68	27.81	-9.85	1.36	V	0.046	16.60			

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8.2 RADIATED SPURIOUS EMISSIONS

■ MODE: LTE B13

■ MODULATION SIGNAL: 5 MHz QPSK

■ DISTANCE: 3 meters

	- /111	Measured	Ant.	Substitute		5.1	Result	Limit	F	RB
Ch	Freq (MHz)	Level (dBm)	Gain (dBd)	Level (dBm)	C.L	Pol	(dBm)	(dBm)	Size	Offset
	1 559.0	-57.21	8.40	-64.54	1.94	V	-58.08	-40.00		
	2 338.5	-59.21	10.00	-64.73	2.45	V	-57.18	-13.00		
23205 (779.5)	3 118.0	-61.03	10.20	-63.40	2.81	V	-56.01	-13.00	1	0
(113.3)	3 897.5	-60.84	10.80	-61.05	3.16	V	-53.41	-13.00		
	4 677.0	-61.92	11.60	-58.97	3.47	V	-50.84	-13.00		
	1 564.0	-58.55	8.40	-65.95	1.96	V	-59.51	-40.00		
	2 346.0	-57.09	10.10	-62.91	2.47	V	-55.28	-13.00		
23230 (782.0)	3 128.0	-60.32	10.20	-62.67	2.82	V	-55.29	-13.00	1	0
(102.0)	3 910.0	-59.65	10.80	-59.80	3.16	V	-52.16	-13.00		
	4 692.0	-60.68	11.60	-58.12	3.48	V	-50.00	-13.00		
	1 569.0	-58.61	8.40	-66.08	1.98	V	-59.66	-40.00		
	2 353.5	-58.66	10.20	-64.35	2.48	V	-56.63	-13.00		
23255 (784.5)	3 138.0	-59.99	10.20	-61.66	2.84	V	-54.30	-13.00	1	0
(784.5)	3 922.5	-60.94	10.80	-60.66	3.16	V	-53.02	-13.00		
	4 707.0	-61.13	11.50	-57.87	3.49	V	-49.86	-13.00		

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■ MODE: <u>LTE B13</u>

■ MODULATION SIGNAL: <u>10 MHz QPSK</u>

■ DISTANCE: 3 meters

Ch	F (1411-)	Measured	Ant.	Substitute	6.1	D-I	Result	Limit	F	RB	
Ch	Freq (MHz)	Level (dBm)	Gain (dBd)	Level (dBm)	C.L	Pol	(dBm)	(dBm)	Size	Offset	
	1 564.0	-58.42	8.40	-65.82	1.96	V	-59.38	-40.00			
	2 346.0	-57.26	10.10	-63.08	2.47	V	-55.45	-13.00			
23230 (782.0)	3 128.0	-60.67	10.20	-63.02	2.82	V	-55.64	-13.00	1	0	
(782.0)	3 910.0	-60.99	10.80	-61.14	3.16	V	-53.50	-13.00			
	4 692.0	-61.15	11.60	-58.59	3.48	V	-50.47	-13.00			

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1559 MHz ~ 1610 MHz BAND

■ OPERATING FREQUENCY: 779.5 MHz, 782.0 MHz, 784.5 MHz

■ MEASURED OUTPUT POWER: 5 MHz QPSK

■ DISTANCE: 3 meters

■ WIDEBAND EMISSION LIMIT: -70 dBW/ MHz (= -40 dBm/ MHz)

Operating Frequency (MHz)	Measured Frequency (MHz)	EMISSION TYPE	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Margin (dB)
779.5	1 573.00		-56.39	8.40	-63.90	1.94	V	-57.44	17.44
782.0	1 562.00	Wide Band	-57.55	8.40	-64.88	1.94	V	-58.42	19.51
784.5	1 570.00		-58.11	8.40	-65.62	1.94	V	-59.16	19.16

Note:

Since the bandwidth of that Spurious emission is greater than 700 Hz, we applied -70 dBW/MHz according to § 27.53(f).

■ OPERATING FREQUENCY: 782.0 MHz

■ MEASURED OUTPUT POWER: 10 MHz QPSK

■ DISTANCE: <u>3 meters</u>

■ WIDEBAND EMISSION LIMIT: -70 dBW/ MHz (= -40 dBm/ MHz)

Operating Frequency (MHz)	Measured Frequency (MHz)	EMISSION TYPE	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Margin (dB)
782.0	1 572.00	Wide Band	-55.36	8.40	-62.83	1.98	V	-56.41	16.41

Note:

Since the bandwidth of that Spurious emission is greater than 700 Hz, we applied -70 dBW/MHz according to § 27.53(f).

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8.3 OCCUPIED BANDWIDTH

Band	Band Width	Frequency (MHz)	Modulation	Resource Block Size	Resource Block Offset	Data (MHz)
			QPSK			4.5200
	E MI I-	700.0	16-QAM	25		4.5038
	5 MHz		64-QAM		0	4.5031
12			256-QAM			4.5248
13		782.0	QPSK			8.9960
	10 1411-		16-QAM			8.9837
	10 MHz		64-QAM	50		8.9991
			256-QAM			9.0083

Note:

1. Plots of the EUT's Occupied Bandwidth are shown Page 34 ~ 41.

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8.4 CONDUCTED SPURIOUS EMISSIONS

Band	Band Width (MHz)	Frequency (MHz)	Frequency of Maximum Harmonic (GHz)	Factor (dB)	Measurement Maximum Data (dBm)	Result (dBm)	Limit (dBm)
		779.5	3.6950	27.976	-67.152	-39.176	
12	5	782.0	3.7104	27.976	-66.771	-38.795	12.00
13		784.5	3.7044	27.976	-67.129	-39.153	-13.00
	10	782.0	3.6810	27.976	-67.272	-39.296	

Note:

- 1. Plots of the EUT's Conducted Spurious Emissions are shown Page 42 \sim 45.
- 2. Conducted Spurious Emissions was Tested QPSK Modulation, Resource Block Size 1 and Resource Block Offset 0
- 3. Result (dBm) = Measurement Maximum Data (dBm) + Factor (dB)
- 4. Factor (dB) = Cable Loss + Attenuator + Power Splitter

Frequency Range (GHz)	Factor [dB]
0.03 - 1	25.270
1 - 5	27.976
5 - 10	28.591
10 - 15	29.116
15 - 20	29.489
Above 20(26.5)	30.131

8.5 BAND EDGE

- Plots of the EUT's Band Edge are shown Page 46 \sim 57.

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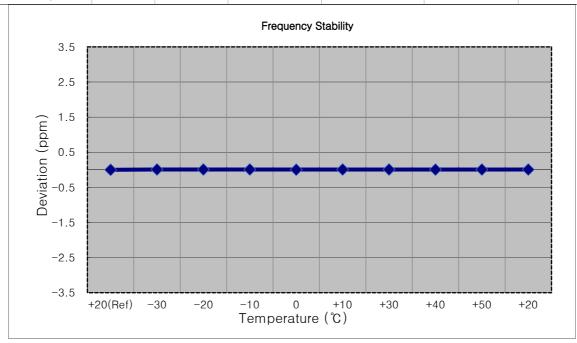
8.6 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE

■ MODE: <u>LTE 13</u>

■ OPERATING FREQUENCY: 779,500,000 Hz
 ■ CHANNEL: 23205 (5 MHz)
 ■ REFERENCE VOLTAGE: 3.880 VDC

■ DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	ppm
100 %		+20(Ref)	779 500 004	0.00	0.000 000	0.0000
100 %		-30	779 500 011	6.90	0.000 001	0.0089
100 %		-20	779 500 011	7.20	0.000 001	0.0092
100 %		-10	779 500 011	7.30	0.000 001	0.0094
100 %	3.880	0	779 500 007	2.90	0.000 000	0.0037
100 %		+10	779 500 011	6.70	0.000 001	0.0086
100 %		+30	779 500 010	6.60	0.000 001	0.0085
100 %		+40	779 500 009	4.70	0.000 001	0.0060
100 %		+50	779 500 010	5.70	0.000 001	0.0073
Batt. Endpoint	3.300	+20	779 500 010	6.00	0.000 001	0.0077



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■ MODE: <u>LTE 13</u>

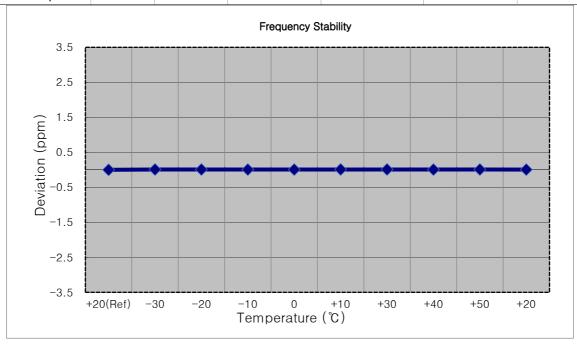
■ OPERATING FREQUENCY: 782,000,000 Hz

■ CHANNEL: <u>23230 (5 MHz)</u>

■ REFERENCE VOLTAGE: 3.880 VDC

■ DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	782 000 009	0.00	0.000 000	0.0000
100 %		-30	782 000 016	6.90	0.000 001	0.0088
100 %		-20	782 000 016	6.90	0.000 001	0.0088
100 %		-10	782 000 014	5.00	0.000 001	0.0064
100 %		0	782 000 014	5.00	0.000 001	0.0064
100 %		+10	782 000 017	7.90	0.000 001	0.0101
100 %		+30	782 000 016	7.30	0.000 001	0.0093
100 %		+40	782 000 014	5.20	0.000 001	0.0066
100 %		+50	782 000 016	6.70	0.000 001	0.0086
Batt. Endpoint	3.300	+20	782 000 014	4.80	0.000 001	0.0061



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■ MODE: <u>LTE 13</u>

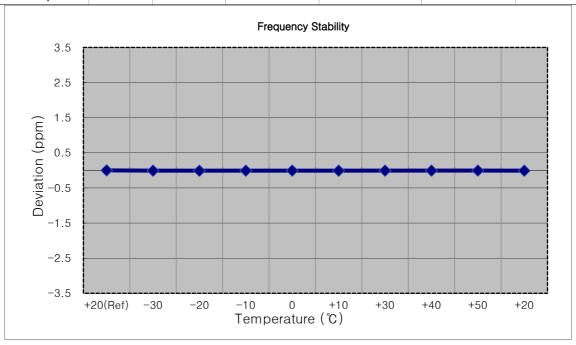
■ OPERATING FREQUENCY: 784,500,000 Hz

■ CHANNEL: <u>23255 (5 MHz)</u>

■ REFERENCE VOLTAGE: 3.880 VDC

■ DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	784 499 992	0.00	0.000 000	0.0000
100 %		-30	784 499 985	-6.50	-0.000 001	-0.0083
100 %		-20	784 499 984	-8.10	-0.000 001	-0.0103
100 %		-10	784 499 986	-6.30	-0.000 001	-0.0080
100 %		0	784 499 986	-5.40	-0.000 001	-0.0069
100 %		+10	784 499 985	-6.70	-0.000 001	-0.0085
100 %		+30	784 499 986	-5.50	-0.000 001	-0.0070
100 %		+40	784 499 985	-6.40	-0.000 001	-0.0082
100 %		+50	784 499 987	-4.60	-0.000 001	-0.0059
Batt. Endpoint	3.300	+20	784 499 985	-7.20	-0.000 001	-0.0092



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■ MODE: <u>LTE 13</u>

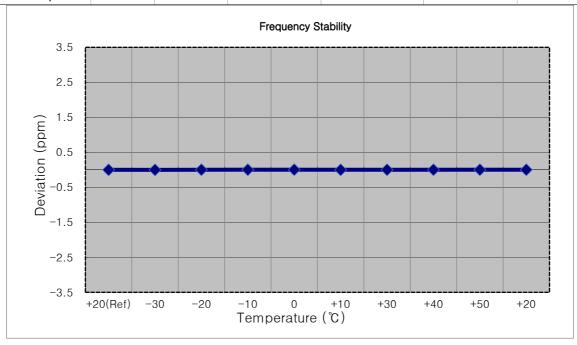
OPERATING FREQUENCY:
 782,000,000 Hz

■ CHANNEL: <u>23230 (10 MHz)</u>

■ REFERENCE VOLTAGE: 3.880 VDC

■ DEVIATION LIMIT: Emission must remain in band

Voltage	Power	Temp.	Frequency	Frequency Error	Deviation	ppm
(%)	(VDC)	(°C)	(Hz)	(Hz)	(%)	
100 %	3.880	+20(Ref)	782 000 002	0.00	0.000 000	0.0000
100 %		-30	782 000 000	-1.20	0.000 000	-0.0015
100 %		-20	782 000 003	1.40	0.000 000	0.0018
100 %		-10	782 000 004	1.90	0.000 000	0.0024
100 %		0	782 000 004	2.50	0.000 000	0.0032
100 %		+10	782 000 001	-0.60	0.000 000	-0.0008
100 %		+30	782 000 003	1.20	0.000 000	0.0015
100 %		+40	782 000 003	1.70	0.000 000	0.0022
100 %		+50	782 000 003	1.80	0.000 000	0.0023
Batt. Endpoint	3.300	+20	782 000 003	1.40	0.000 000	0.0018



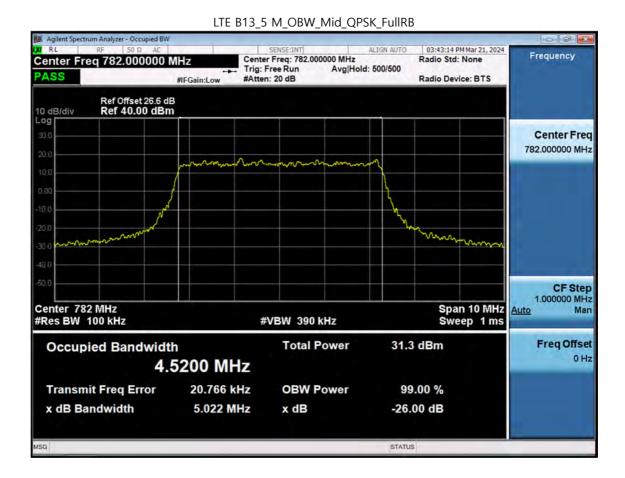
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9. TEST PLOTS

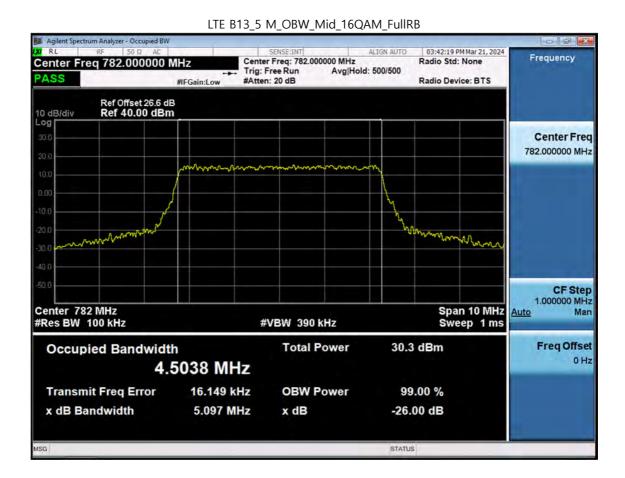
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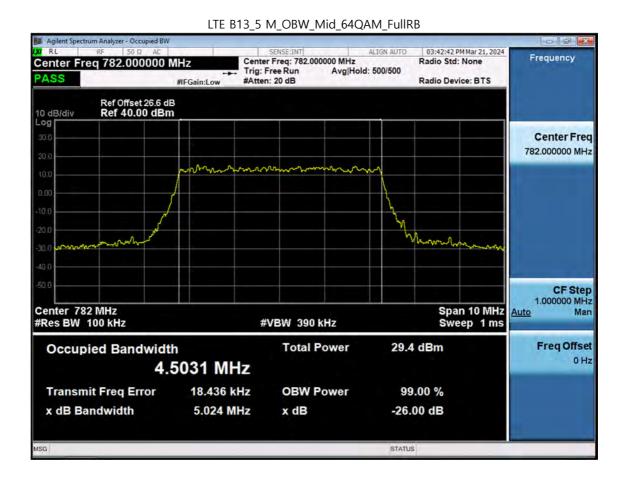
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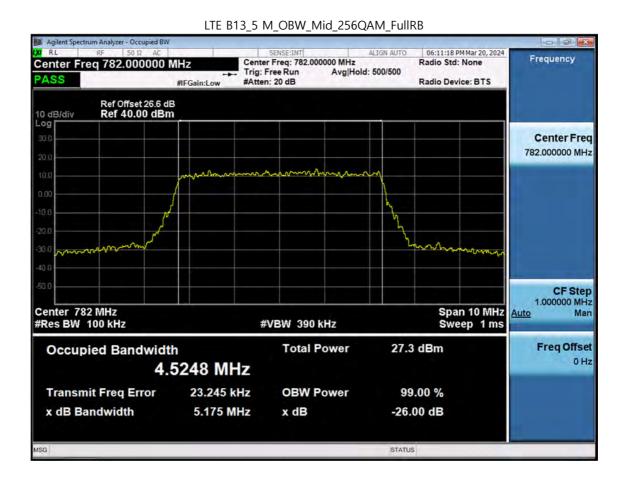
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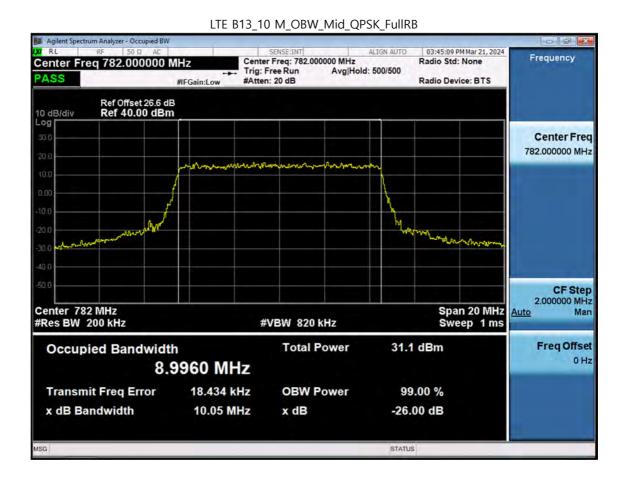
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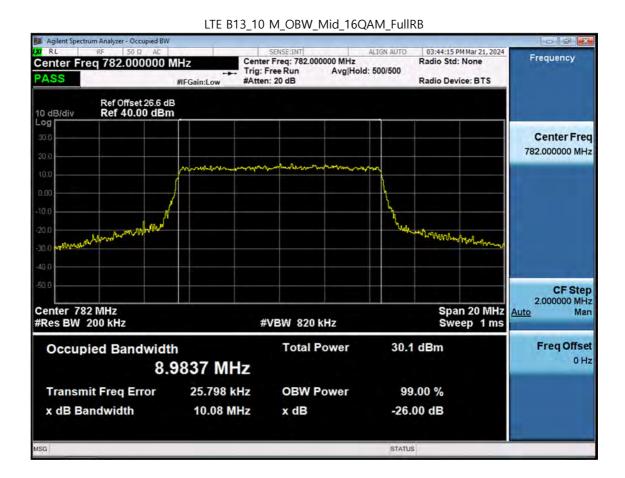
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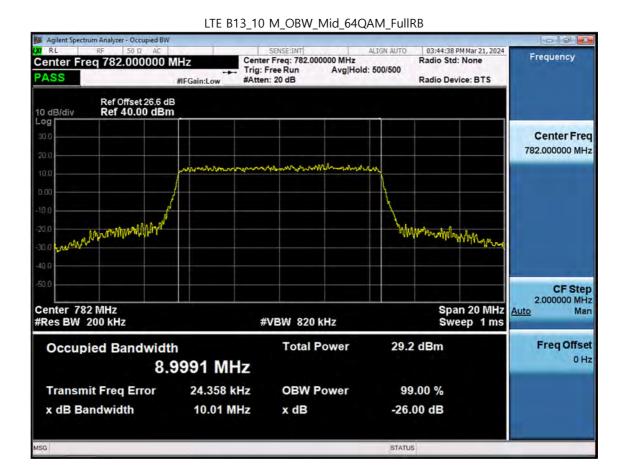
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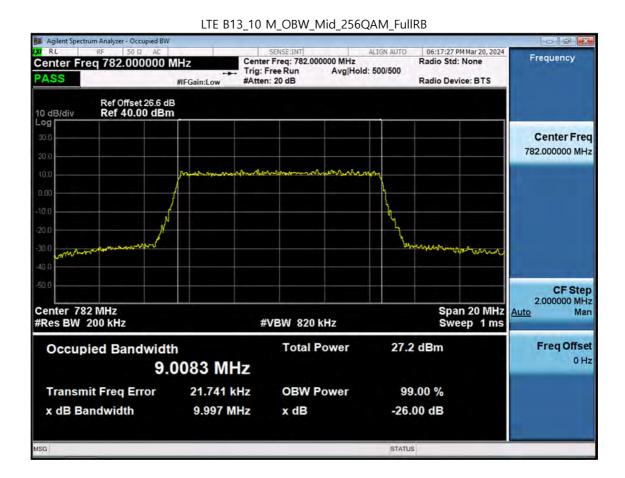


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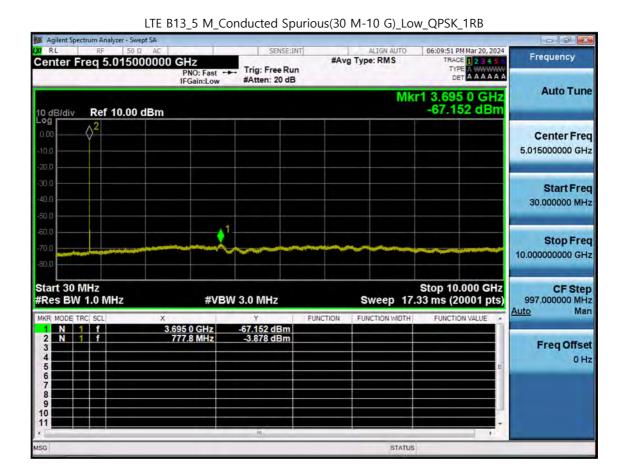
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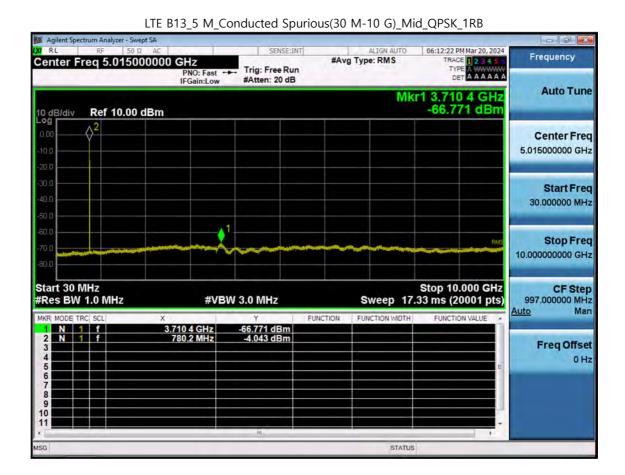






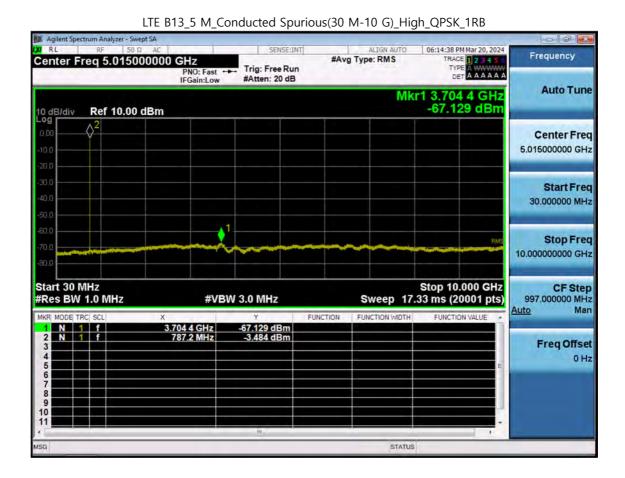
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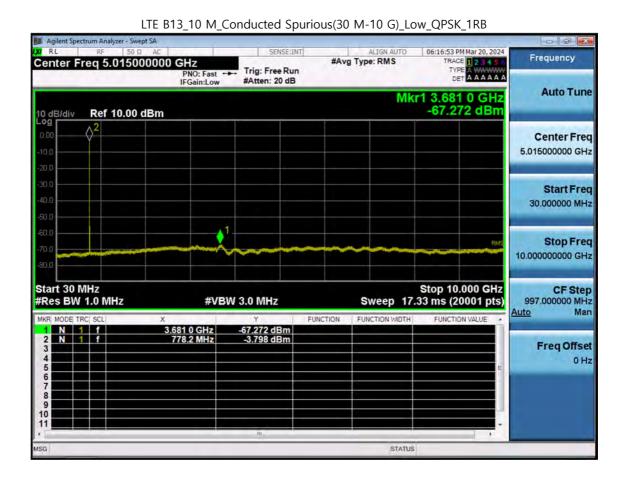
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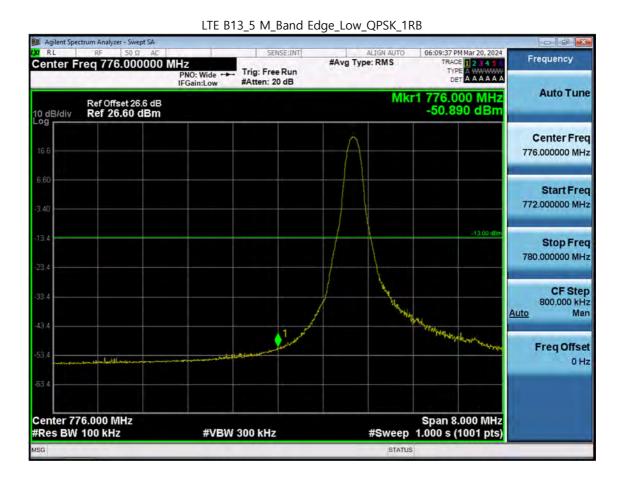
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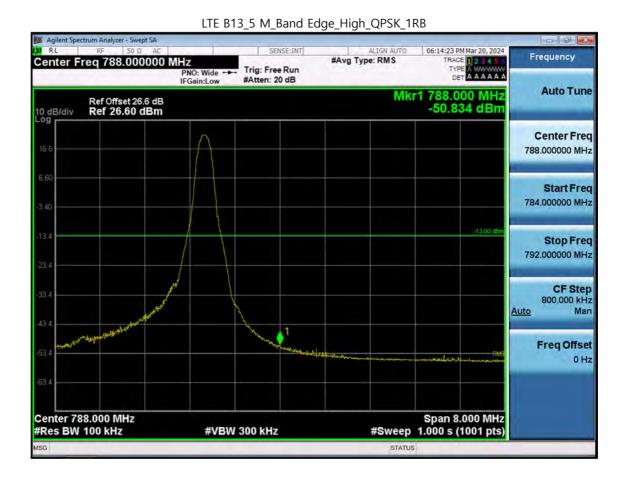
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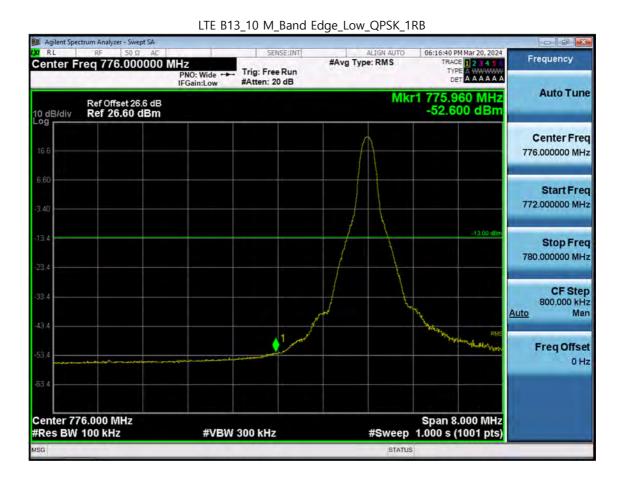
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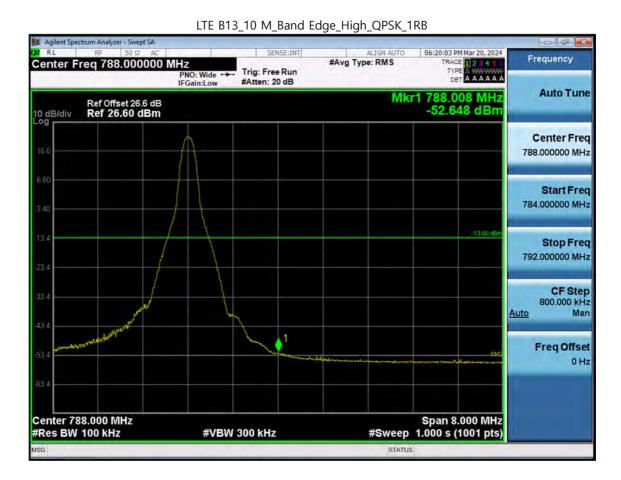
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10. ANNEX A_ TEST SETUP PHOTO

Please refer to test setup photo file no. as follows;

No.	Description
1	HCT-RF-2405-FC005-P

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